## Search Notes



Appl	icati	ion/	Con	trol	No.	

10581578

Applicant(s)/Patent Under Reexamination

HAYASHI ET AL.

Examiner

Art Unit

Brian Walck

4181

## SEARCHED

Class	Subclass	Date	Examiner
252	184	1/30/2009	BDW
423	441-442	1/30/2009	BDW
502	416-418,423,426,427	1/30/2009	BDW
252	184	11/19/2009	BDW
423	441-442	11/19/2009	BDW
502	416-418,423,426,427	11/19/2009	BDW

## **SEARCH NOTES**

<u> </u>		
Search Notes	Date	Examiner
EAST search history attached	1/29/2009	BDW
NPL search done in STN	1/29/2009	BDW
Consulted Jerry Lorengo and Greg Mills on 1/29/2009 on 112 1st	1/29/2009	BDW
Consulted Stu Hendrickson on 1/30/2009 on prior art and 112 1st	1/30/2009	BDW
Inventor search done in eDAN	1/30/2009	BDW
Updated EAST search	11/19/2009	BDW
Updated inventor search in eDAN	11/19/2009	BDW
Consulted Stuart Hendrickson	11/13/2009	BDW

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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